


Search Notes 	Application/Control No. 10023010	Applicant(s)/Patent Under Reexamination HADFIELD ET AL.
	Examiner Maikhanh Nguyen	Art Unit 2176

SEARCHED			
Class	Subclass	Date	Examiner
715	200,205,210,229,234,255,256,272,273,751,760	10/21/08	MK
707	1,3, 6, 7, 10,100,101,200, 201,203	10/21/08	MK
709	201,202,203,205,214,215,217	10/21/08	MK

SEARCH NOTES			
Search Notes		Date	Examiner
West Updated (USPAT, USPGPub) & Interference Search - See Search History		10/21/08	MK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
715	229,234,255, 751	10/21/08	MK
707	7,201	10/21/08	MK
709	203	10/21/08	MK

--	--